

Search Notes

Application/Control No.

10/774,689

Examiner

Benny Q. Tieu

Applicant(s)/Patent under
Reexamination

HOLDER, LOUIS

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	221.01- 221.15 219 220.01	6/24/2006	BQT
370	352-356		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/24/2006	BQT